

HSB-LN2I

PCB Rev. A1.2

Temperature/Humidity Test Report

Report NO:

Summary	<p><input checked="" type="checkbox"/> Pass <input type="checkbox"/> Fail</p> <p>Note : There is/are ____ defect(s) not list in the report, please check it in the DTS Website.</p> <p><input type="checkbox"/> Pass with Deviation</p> <p>Comment:</p>

Issue date

2014-02-19

Approval

Daniel Peng

Test Engineer

Edwin Luo

Test item list

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3. *Temp./humidity power on/off test* ----- 4
4. *Temperature variation operation test* ----- 5
5. *Cold start and hot start test* ----- 6

Testing Result

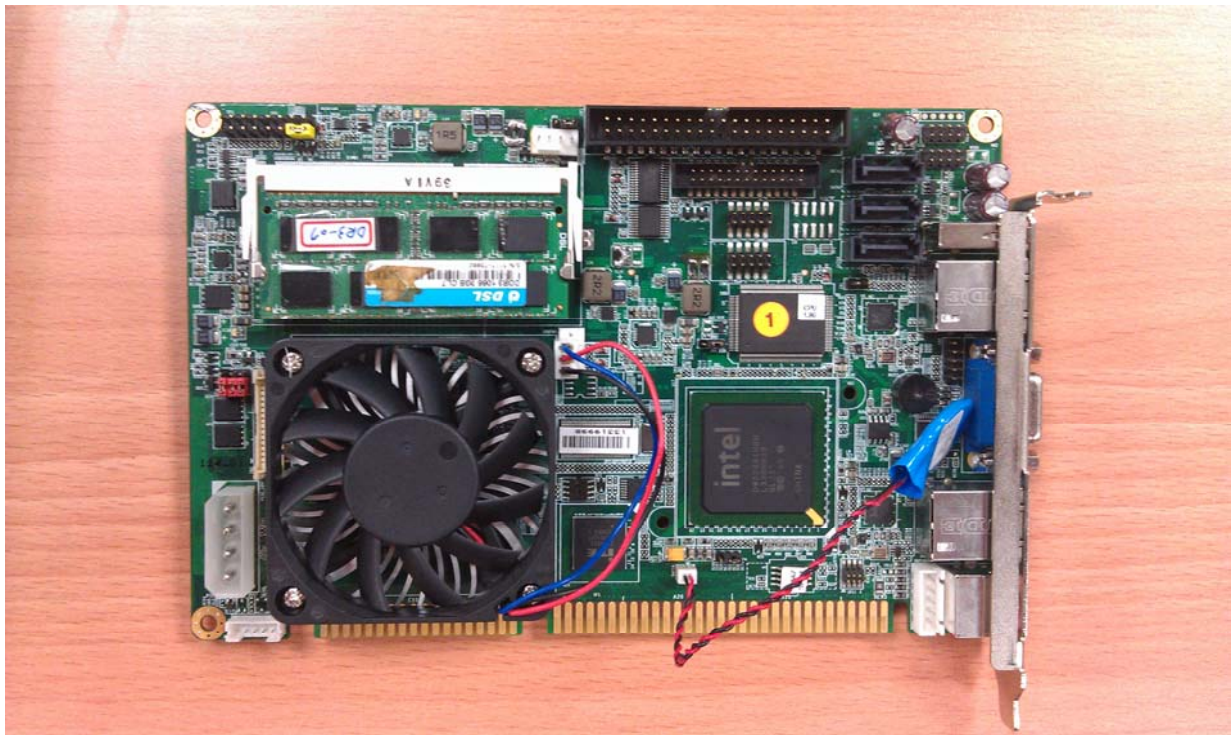
Num	Test item list	Result	Remark
1	Temp./humidity power on/off test	Pass	
2	Temperature variation operation test	Pass	
3	Cold start and hot start test	Pass	

Configuration of EUT

Test Product: HSB-LN2I A1.2

Sample Configuration & Quantity Under Test:

1. CPU: Intel® Atom™ D525/N455
2. Chipset: ICH8M
3. Memory: DSL DDR3 1066 2GB CL7
4. Test Software: Windows 7 x32 with SP1/ Run PassMark BurnInTest Pro v7.0 build 1004
5. Storage: Seagate ST500DM002 500GB
6. AT Power Supplier: EMACS HG2-6400P
7. Heat-sink: As the following picture.
8. BIOS:HLNIAM12



Temp./humidity power on/off test

Test Date: 2014/02/03~2014/02/06

Test Site: AAEON Taichung Internal Lab

Test Standard: Reference IEC 68-2-30 Testing procedures
Test Db: Damp Heat Test

Test Equipment:

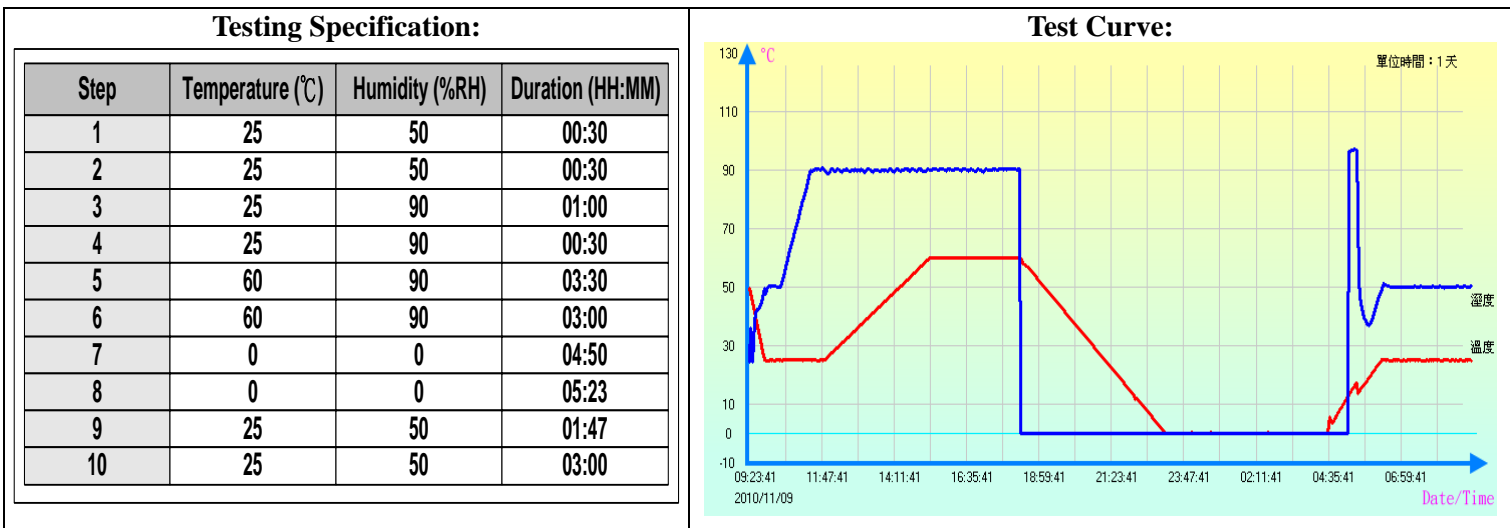
Programmable Temperature & Humidity Chamber
TERCHY. TECH. CORP.

Model: MHK-225NK

Date of Calibration: 2013/03/08

Serial Number: 1000122

Temperature & Humidity Power On/Off Test:



Test Result:

No problem was found during the temperature & humidity power on/off test.

Test Method	Actual	Successful	Failure rate
Power On/Off	4295	4295	0%
Note: Failure rate need to under 0.0%.			

Temperature variation operation test

Test Date: 2014/01/27~2014/01/28

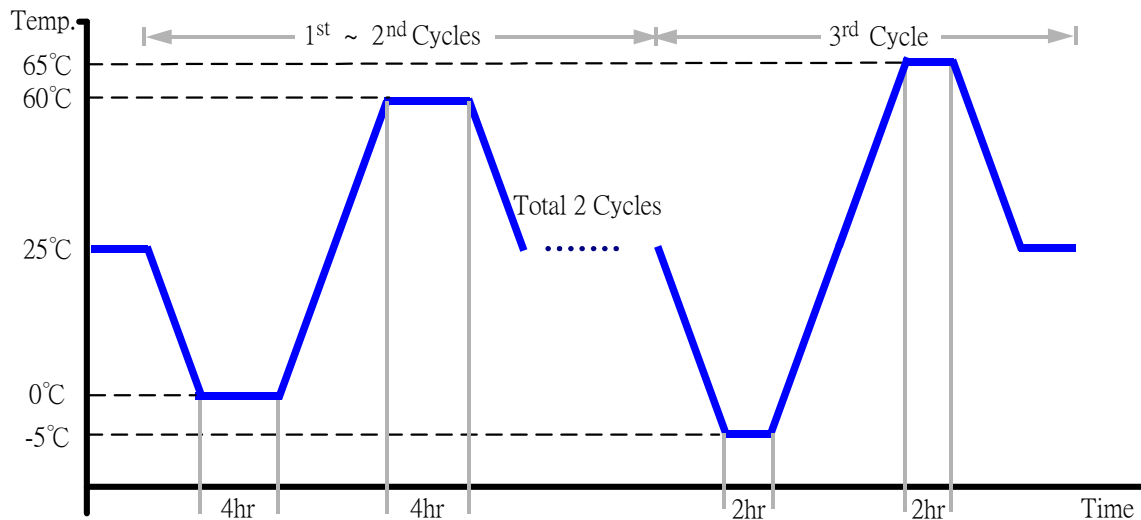
Test Site: AAEON Taichung Internal Lab

Test Standard: Reference IEC 68-2-14 Testing procedures
Test N: Change of temperature Test

Test Equipment:
Programmable Temperature & Humidity Chamber
TERCHY. TECH. CORP.
Model: MHK-225NK
Date of Calibration: 2013/03/08
Serial Number: 1000122

Temperature & Humidity Cycle Test:

1. Test Low Temperature: 0°C (1~2 cycles)
-5°C (3rd cycle)
2. Test High Temperature: 60°C (1~2 cycles)
65°C (3rd cycle)
3. Test dwell time: 4Hrs (1~2 cycles)
2Hrs (3rd cycle)
4. Temperature slope: 2°C/min
5. Test cycle: 3 cycles
6. Test Environment Curve:



Test Result:

No problem was found during the temperature variation operation test.

Cold start and hot start test

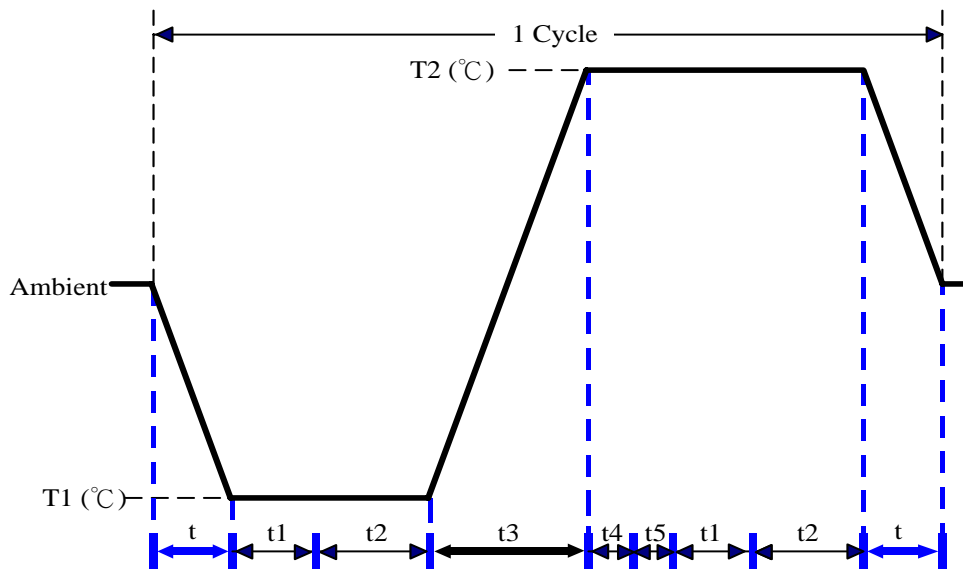
Test Date: 2014/01/18~2014/01/29

Test Site: AAEON Taichung Internal Lab

Test Standard: Reference IEC 68-2-14 Testing procedures
Test N: Change of temperature Test

Test Equipment:
Programmable Temperature & Humidity Chamber
TERCHY. TECH. CORP.
Model: MHK-225NK
Date of Calibration: 2013/03/08
Serial Number: 1000122

Test Condition:



Parameters	Description
T1	-5°C
T2	65°C
t1	1 hrs
t2	2 hrs
t4, t5	30 min
t, t3	2°C/min
n (Cycle)	1

t,t3 = temprature slope
t, t1: Power Off
t2: Power on/off test 10 times (on 2 min / off 5min)
t3,t4: Run PassMark Burn In Test
t5: Win XP Software restart test 2 times
Test Software:Windows XP

Test Result:

- No problem was found during the cold start test.
- No problem was found during the hot start test.